### **N-Channel**

### **SIC MOSFET**



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### **Features**

- High Operating Temperature 175°C
- Low On-Resistance RDS (on) 0.04Ω
- Fast Switching Speed and Low EMI
- High Peak Current Ratings
- Low Total Gate Charge 132nC for Low Switching Losses
- Improved Power Density: The combination of high voltage, fast switching, and low losses.
- Reduced System Size and Weight

### **Key Values**

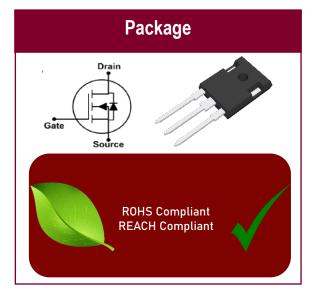
PARAMETER	VALUE	UNIT
$BV_{DSS}$	1200	V
$R_{DS(ON),typ}(20V)$	40	mΩ
$V_{GS(TH),typ}$	2.0~4.0	V
$E_{ON}$	1.2	mJ
$E_{OFF}$	0.54	mJ
$I_D$ (at 25°C)	66	Α

# Part Number QS1200SCM66 Package TO247 Marking Q

### **Applications**

SiC MOSFETs are well-suited for applications where high-power density, high-frequency operation, and improved efficiency are critical. Their characteristics make them a preferred choice in a variety of modern electronic systems.

- Electric Vehicles
- Solar Inverters
- Uninterruptible Power Supplies (UPS)
- Switched-Mode Power Supplies (SMPS)
- Industrial Motor Drives
- Renewable Energy Systems
- High-Frequency Power Converters
- Grid-Tied Energy Storage Systems





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### ABSOLUTE MAXIMUM RATINGS (Ta = 25°C Unless otherwise specified)

Parameter	Symbol	Value	Unit			
Drain-to-Source Voltage	$V_{DSS}$	1200	V			
Maximum Gate-to-Source Voltage	$V_{GSmax}$	$-10 \sim +25$				
Recommended operations values of gate to source voltage	$V_{GSop(DC)}$	$-5.0 \sim +20$				
Recommended operations values of gate to source voltage (f>1Hz)	$V_{GSop(AC)}$	$-5.0 \sim +20$				
Continuous Drain Current	$I_D$	66.0	Α			
Continuous Drain Current at $T_c=100^{\circ}$ C		47.0				
Pulsed Drain Current at $VGS = 10V^2$	$I_{DM}$	164				
Single Pulse Avalanche Energy	$E_{AS}$	288	mJ			
$(V_{DD} = 50V, V_{GS} = 15V, R_G = 25\Omega, L = 1mH)$						
Power Dissipation	$P_D$	333	W			
Derating Factor above 25°C		2.20	°C/W			
Soldering Temperature, Distance of 1.6mm from case	$T_L$	300	°C			
for 10 seconds						
Operating and Storage Temperature Range	$T_J, T_{STG}$	-55 <i>to</i> 175				
Caution: Stresses greater than those listed in the Absolute Maximum Ratings may cause						
permanent damage to devices.						
Thermal Characteristics						
Thermal Resistance, Junction-to-Case	$R_{8JC}$	0.45	°C/W			
Thermal Resistance, Junction-to-Ambient	$R_{8JA}$	40				

# **ELECTRICAL CHARACTERISTICS** (Ta = 25°C Unless otherwise specified)

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Parameter	Symbol	Test Conditions	Value			Unit
			Min	Тур	Max	
OFF Characteristics ( $T_J = 25$ °C unless	s otherwise spe	ecified)	•			
Drain-to-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V,I_D=100\mu A$	1200	_	_	V
Drain-to-Source Leakage Current	$I_{DSS}$	$V_{DS}=1200V, V_{GS}=0V$	-	-	100	μΑ
Gate-to-Source Leakage Current	$I_{Gss+}$	$V_{DS} = 0V, V_{GS} = 20V$	_	_	100	nA
Gate-to-Source Leakage Current	$I_{Gss-}$	$V_{DS} = 0V, V_{GS} = -10V$	_	_	-100	nA
ON Characteristics ( $T_I = 25$ °C unless	otherwise spec	l cified)				
Static Drain-to-Source On	$R_{DS(ON)}$	$V_{GS} = 20V, I_D = 40A$	_	40	50	$m\Omega$
Resistance <sup>3</sup>	, ,	$V_{GS} = 20V, I_D = 40A, T_J = 150$ °C	_	55	_	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 10mA$	2.0	_	4.0	V
Dynamic Characteristics (Essentially in		perating temperature)				
Input Capacitance	$C_{iss}$	$V_{GS} = 0V$	-	2027	_	рF
Reverse Transfer Capacitance	$C_{rss}$	$V_{DS} = 800V$ $f = 1MHz$	-	11	-	
Output Capacitance	$C_{oss}$		_	115	_	
Gate Series Resistance	$R_g$	f = 1MHz	_	3.2	_	Ω
Total Gate Charge	$Q_g$	$V_{DD} = 800V$	_	132	_	пС
Gate-to-Source Charge	$Q_{gs}$	$I_D = 40A$	_	25	_	
Gate-to-Drain (Miller) Charge	$Q_{gd}$	$V_{GS} = -\frac{5}{20V}$	_	61	_	
Resistive Switching Characteristics (Es	sentially indepe	endent of operating temperature)				
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 800V$	_	11	-	nS
Rise Time	t <sub>rise</sub>	$I_D = 40A$	_	31	_	
Turn-off Delay Time	$t_{d(off)}$	$V_{GS} = -\frac{3.5}{18V}$	_	33	_	
Fall Time	$t_{fall}$	$R_G = 2.0\Omega$	_	27	_	
Turn-On Switching Energy	$E_{ON}$	L = 1mH	_	1.2	-	mJ
Turn-Off Switching Energy	$E_{OFF}$	1	_	0.54	_	•
Source-Drain Body Diode Characteristic		unless otherwise specified)	1	1	-	
Continuous Source Current	$I_{SD}$	Maximum Ratings	_	_	66	Α
Diode Forward Voltage	$V_{SD}$	$I_S = 20A, V_{GS} = 0V$	_	4.2	-	V
Reverse Recovery Time	$t_{rr}$	$V_{GS} = 0V$	_	46	-	nS
Reverse Recovery Charge	$Q_{rr}$	$I_F = 40A$	_	278	-	пС
Peak Reverse Recovery Charge	$I_{mm}$	$\frac{di}{dt} = 1000A/\mu s$	-	9.3	-	Α

<sup>-</sup> TJ=25°C to 175°C

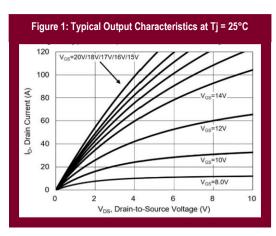
<sup>-</sup> Repetitive rating, pulse width limited by maximum junction temperature

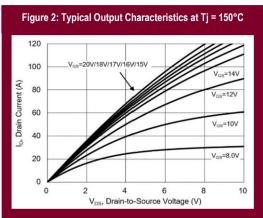
<sup>-</sup>Pulse width≤380μs; duty cycle≤2%

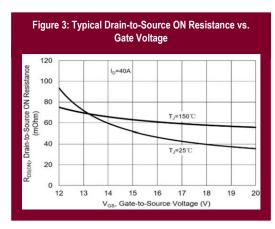
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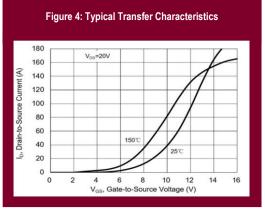
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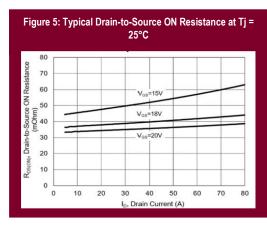


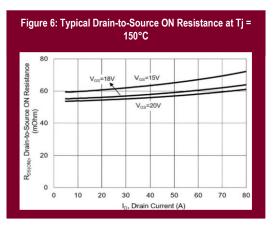








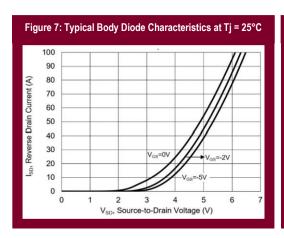


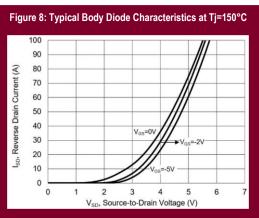


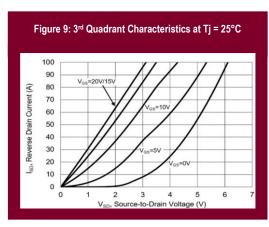
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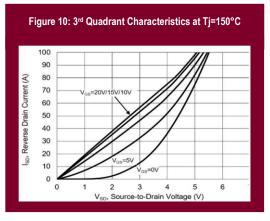
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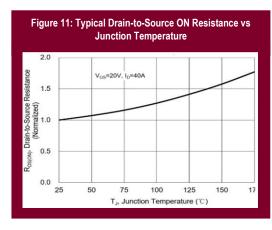


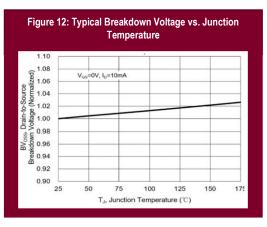








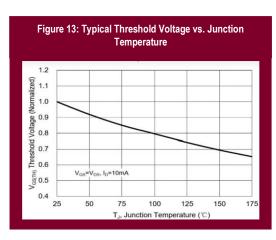


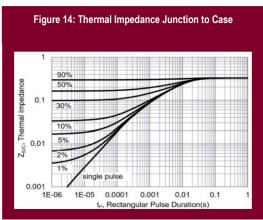


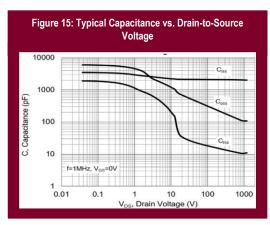
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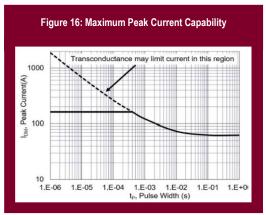
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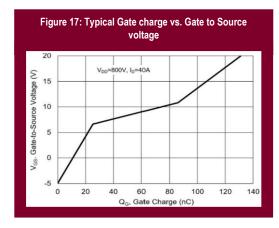


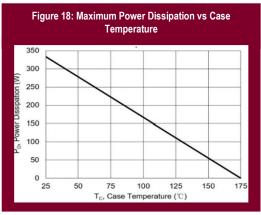








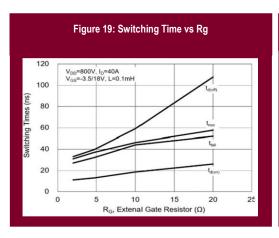


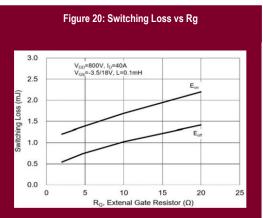


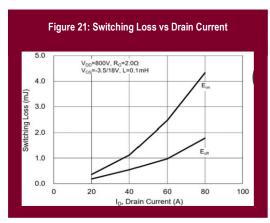
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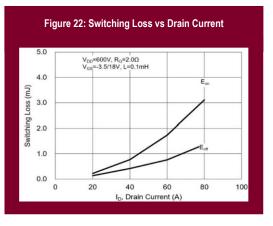
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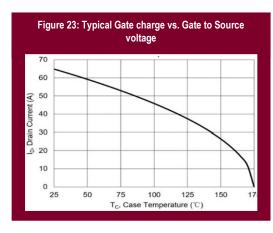


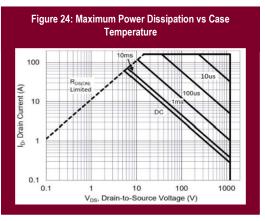










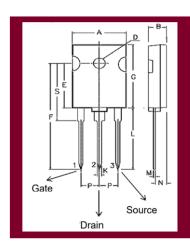


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DIM	MIN	MAX
Α	15.20	15.80
В	4.90	5. 10
D	3.90	4.10
E	14.20	14.80
F	28.20	30.50
G	19.50	19.80
K	1.00	1.30
L	14.10	17.50
M	0.40	0.60
N	2.50	2.75
P	5.21	5.72
S	18.25	19.25

### Pin configuration:

- 1. Gate
- 2. Drain
- 3. Source



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### Disclaimer:

The products described in this datasheet are intended for general-purpose applications, and their specifications and performance characteristics have been established under standard operating conditions. They are not specifically designed or authorized for use in life-critical or life-support systems. Life-critical systems are those in which the failure of a semiconductor device could lead to loss of life, severe injury, or severe damage to property.

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